Notice of References Cited Application/Control No. 10/509,481 Examiner Elias Ullah Applicant(s)/Patent Under Reexamination YOON ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | Α | US-5,548,425 | 08-1996 | Adachi et al. | 349/112 |
| * | В | US-6,188,452 | 02-2001 | Kim et al. | 349/43 |
| * | С | US-6,159,779 | 12-2000 | Huang et al. | 438/158 |
| * | D | US-5,767,827 | 06-1998 | Kobayashi et al. | 345/87 |
| * | Ε | US-6,136,625 | 10-2000 | Nakazawa, Takashi | 438/30 |
| * | F | US-6,156,583 | 12-2000 | Hwang, Kwang Jo | 438/30 |
| * | G | US-5,652,159 | 07-1997 | Hirano, Naoto | 438/160 |
| * | Н | US-6,184,070 | 02-2001 | Park, Sung Kge | 438/159 |
| | - | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | м | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| | HON-FATERI DOCUMENTS | | | | | | | |
|---|----------------------|---|--|--|--|--|--|--|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | | | |
| | U | | | | | | | |
| | V | | | | | | | |
| | w | | | | | | | |
| | х | | | | | | | |

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.